

Application/Control No.	Applicant(s)/Patent under Reexamination
10/790.211	AOKI, TAKAAKI

 10/790,211
 AOKI, TAKAAKI

 Examiner
 Art Unit

 William Kraig
 2815

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	330, 522	7/6/2006	WFK
257	e23.013	7/6/2006	WFK
257	e21.581	7/6/2006	WFK
438	319, 411	7/6/2006	WFK
438	421, 619	7/6/2006	WFK

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examine	

DATE 7/6/2006	EXMR WFK
7/6/2006	WFK